

Notice of References Cited	Application/Control No. 10/790,825	Applicant(s)/Patent Under Reexamination JEN ET AL.	
	Examiner Jennifer T. Nguyen	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0057484	03-2005	Diefenbaugh et al.	345/102
*	B	US-2005/0104838	05-2005	Sasaki, Takashi	345/102
*	C	US-6,839,048	01-2005	Park, Cheol-Woo	345/102
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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